Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/521,068	EZAWA ET AL.
Examiner	Art Unit
Matthew G. Kayrish	2627

SEARCHED				
Class	Subclass	Date	Examiner	
720	643	2/27/2006	мк	
		. —		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
720	643	2/27/2006	MK	
	SPG-PUB ch History)	2/27/2006	МК	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, IBD_TDB, DERWENT) (See Attached Search History)	2/24/2006	MK	
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, IBD_TDB, DERWENT) (See Attached Search History)	2/27/2006	МК	